INFORMATION DISCLOSURE STATEMENT

Applicant : Maruyama, et al.

App. No : 10/522036

Filed: January 19, 2005

For : CHEMICAL AMPLIFICATION TYPE

POSITIVE PHOTORESIST COMPOSITION AND RESIST PATTERN FORMING METHOD

Examiner : Lee, Sin J.

Art Unit : 1752

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing 2 references to be considered by the Examiner. Also enclosed is 1 foreign patent reference and/or non-patent literature as listed on the Information Disclosure Statement.

This Information Disclosure Statement is being filed after the mailing date of a final action or after the mailing date of a Notice of Allowance. This Statement is accompanied by the fee set forth in 37 C.F.R. § 1.17(p). The Commissioner is hereby authorized to charge any additional fees which may be required or to credit any overpayment to Account No. 11-1410.

CERTIFICATION UNDER 37 C.F.R. § 1.97(e)(1)

I hereby certify that each item of information contained in this Statement was first cited in a communication from a foreign Patent Office in a counterpart foreign application not more than

Appl. No.

10/522036

Filed

January 19, 2005

Docket No. SHIGA7.004APC Customer No. 20,995

three months prior to the filing of this Information Disclosure Statement.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Bv:

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IDS 3458621/LRR 022207

PTO/SB/08 Equivalent

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

(Multiple sheets used when necessary)
SHEET 1 OF 1

Application No.	10/522036
Filing Date	January 19, 2005
First Named Inventor	Maruyama, et al.
Art Unit	1752
Examiner	Lee, Sin J.
Attorney Docket No.	SHIGAZ DOMARC

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1.	6,673,512 B1	01-06-2004	Kazuya, et al.	
			<u> </u>		

			FOREIGN PATE	NT DOCUMENTS		
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T¹
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NON PATENT LITERATURE DOCUMENTS					
Examiner Cite No.		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
	2.	Office Action dated January 10, 2007 in connection with Korean Patent Application No. 10-2006-7021725.			
			-		

3457989/LRR 022207

Examiner Signature

Date Considered

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T¹ - Place a check mark in this area when an English language Translation is attached.